## **74ALVC32**

# Quad 2-input OR gate Rev. 3 — 20 January 2014

Product data sheet

#### 1. **General description**

The 74ALVC32 is a quad 2-input OR gate.

Schmitt trigger action on all inputs makes the device tolerant of slow rise and fall times.

#### 2. **Features and benefits**

- Wide supply voltage range from 1.65 V to 3.6 V
- 3.6 V tolerant inputs/outputs
- CMOS low power consumption
- Direct interface with TTL levels (2.7 V to 3.6 V)
- Power-down mode
- Latch-up performance exceeds 250 mA
- Complies with JEDEC standards:
  - ◆ JESD8-7 (1.65 V to 1.95 V)
  - ◆ JESD8-5 (2.3 V to 2.7 V)
  - ◆ JESD8B/JESD36 (2.7 V to 3.6 V)
- ESD protection:
  - ♦ HBM JESD22-A114E exceeds 2000 V
  - ♦ MM JESD22-A115-A exceeds 200 V

#### **Ordering information** 3.

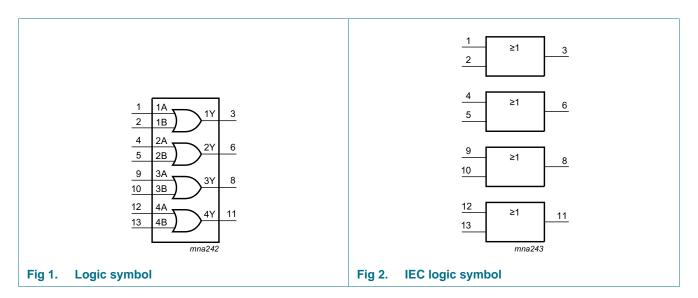
Table 1. **Ordering information** 

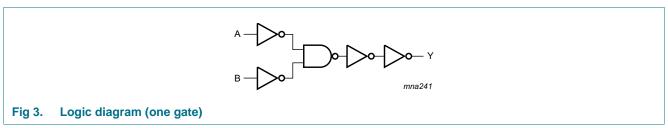
Type number	Package									
	Temperature range	Name	Description	Version						
74ALVC32D	–40 °C to +85 °C	SO14	plastic small outline package; 14 leads; body width 3.9 mm	SOT108-1						
74ALVC32PW	–40 °C to +85 °C	TSSOP14	plastic thin shrink small outline package; 14 leads; body width 4.4 mm	SOT402-1						
74ALVC32BQ	–40 °C to +85 °C	DHVQFN14	plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 14 terminals; body 2.5 $\times$ 3 $\times$ 0.85 mm	SOT762-1						



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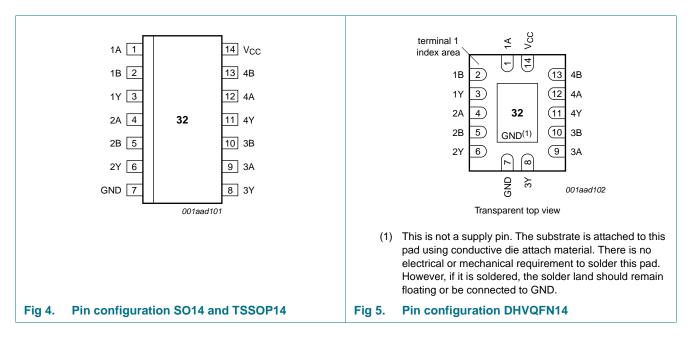
## 4. Functional diagram





## 5. Pinning information

#### 5.1 Pinning



#### 5.2 Pin description

Table 2. Pin description

Symbol	Pin	Description
nA	1, 4, 9, 12	data input
nB	2, 5, 10, 13	data input
nY	3, 6, 8, 11	data output
$V_{CC}$	14	supply voltage
GND	7	ground (0 V)

## 6. Functional description

Table 3. Function table[1]

Input nA	Input nB	Output nY
L	L	L
L	Н	Н
Н	L	Н
Н	Н	Н

<sup>[1]</sup> H = HIGH voltage level L = LOW voltage level

## 7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Min	Max	Unit
$V_{CC}$	supply voltage			-0.5	+4.6	V
I <sub>IK</sub>	input clamping current	V <sub>I</sub> < 0 V		-50	-	mA
VI	input voltage			-0.5	+4.6	V
I <sub>OK</sub>	output clamping current	$V_O > V_{CC}$ or $V_O < 0 \text{ V}$		-	±50	mA
Vo	output voltage	output HIGH or LOW state	[1] [2]	-0.5	$V_{CC} + 0.5$	V
		output 3-state		-0.5	+4.6	V
		power-down mode, $V_{CC} = 0 V$	[2]	-0.5	+4.6	V
I <sub>O</sub>	output current	$V_O = 0 V \text{ to } V_{CC}$		-	±50	mA
I <sub>CC</sub>	supply current			-	100	mA
I <sub>GND</sub>	ground current			-100	-	mA
T <sub>stg</sub>	storage temperature			-65	+150	°C
P <sub>tot</sub>	total power dissipation	$T_{amb} = -40  ^{\circ}\text{C} \text{ to } +85  ^{\circ}\text{C}$	<u>[3]</u>	-	500	mW

<sup>[1]</sup> The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

<sup>[2]</sup> When  $V_{CC} = 0 \text{ V}$  (power-down mode), the output voltage can be 3.6 V in normal operation.

<sup>[3]</sup> For SO14 packages: above 70 °C derate linearly with 8 mW/K.
For TSSOP14 packages: above 60 °C derate linearly with 5.5 mW/K.
For DHVQFN14 packages: above 60 °C derate linearly with 4.5 mW/K.

## 8. Recommended operating conditions

Table 5. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CC}$	supply voltage		1.65	3.6	V
VI	input voltage		0	3.6	V
Vo	output voltage	output HIGH or LOW state	0	$V_{CC}$	V
	input voltage output voltage ambient temperature	output 3-state	0	3.6	V
		power-down mode; V <sub>CC</sub> = 0 V	0	3.6	3.6 V V <sub>CC</sub> V 3.6 V 485 °C 20 ns/V
T <sub>amb</sub>	ambient temperature	in free air	-40	+85	°C
$\Delta t/\Delta V$	input transition rise and fall rate	$V_{CC} = 1.65 \text{ V to } 2.7 \text{ V}$	0	20	ns/V
		V <sub>CC</sub> = 2.7 V to 3.6 V	0	10	ns/V

#### 9. Static characteristics

Table 6. Static characteristics

At recommended operating conditions. Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	T <sub>amb</sub> =	$T_{amb} = -40$ °C to +85 °C					
			Min	Typ[1]	Max				
$V_{IH}$	HIGH-level input voltage	V <sub>CC</sub> = 1.65 V to 1.95 V	$0.65 \times V_{CC}$	-	-	V			
		$V_{CC}$ = 2.3 V to 2.7 V	1.7	-	-	V			
		$V_{CC}$ = 2.7 V to 3.6 V	2.0	-	-	V			
V <sub>IL</sub>	LOW-level input voltage	V <sub>CC</sub> = 1.65 V to 1.95 V	-	-	$0.35 \times V_{CC}$	V			
		$V_{CC}$ = 2.3 V to 2.7 V	-	-	0.7	V			
		V <sub>CC</sub> = 2.7 V to 3.6 V	-	-	8.0	V			
V <sub>OH</sub>	HIGH-level output voltage	$V_I = V_{IH}$ or $V_{IL}$							
		$I_{O} = -100 \mu A$ ; $V_{CC} = 1.65 \text{ V to } 3.6 \text{ V}$	$V_{CC}-0.2$	-	-	V			
		$I_O = -6 \text{ mA}; V_{CC} = 1.65 \text{ V}$	1.25	1.51	-	V			
		$I_{O} = -12 \text{ mA}; V_{CC} = 2.3 \text{ V}$	1.8	2.10	-	V			
		$I_{O} = -18 \text{ mA}; V_{CC} = 2.3 \text{ V}$	1.7	2.01	-	V			
		$I_O = -12$ mA; $V_{CC} = 2.7$ V	2.2	2.53	-	V			
		$I_{O} = -18 \text{ mA}; V_{CC} = 3.0 \text{ V}$	2.4	2.76	-	V			
		$I_O = -24$ mA; $V_{CC} = 3.0$ V	2.2	2.68	-	V			
V <sub>OL</sub>	LOW-level output voltage	$V_I = V_{IH}$ or $V_{IL}$							
		$I_O$ = 100 $\mu$ A; $V_{CC}$ = 1.65 V to 3.6 V	-	-	0.2	V			
		$I_{O} = 6 \text{ mA}; V_{CC} = 1.65 \text{ V}$	-	0.11	0.3	V			
		$I_{O} = 12 \text{ mA}; V_{CC} = 2.3 \text{ V}$	-	0.17	0.4	V			
		$I_O = 18 \text{ mA}; V_{CC} = 2.3 \text{ V}$	-	0.25	0.6	V			
		$I_{O} = 12 \text{ mA}; V_{CC} = 2.7 \text{ V}$	-	0.16	0.4	V			
		$I_{O}$ = 18 mA; $V_{CC}$ = 3.0 V	-	0.23	0.4	V			
		$I_{O} = 24 \text{ mA}; V_{CC} = 3.0 \text{ V}$	-	0.30	0.55	V			
I	input leakage current	$V_{CC} = 3.6 \text{ V}; V_{I} = 3.6 \text{ V or GND}$	-	±0.1	±5	μΑ			
l <sub>OFF</sub>	power-off leakage current	$V_{CC} = 0 \text{ V}$ ; $V_{I}$ or $V_{O} = 0 \text{ V}$ to 3.6 V	-	±0.1	±10	μΑ			

Table 6. Static characteristics ... continued

At recommended operating conditions. Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	T <sub>amb</sub> :	$T_{amb} = -40  ^{\circ}\text{C} \text{ to } +85  ^{\circ}\text{C}$				
			Min	Typ[1]	Max			
I <sub>CC</sub>	supply current	$V_{CC} = 3.6 \text{ V}; V_I = V_{CC} \text{ or GND}; I_O = 0 \text{ A}$	-	0.2	10	μΑ		
$\Delta I_{CC}$	additional supply current	per input pin; $V_{CC} = 3.0 \text{ V}$ to 3.6 V; $V_I = V_{CC} - 0.6 \text{ V}$ ; $I_O = 0 \text{ A}$	-	5	750	μΑ		
Cı	input capacitance		-	3.5	-	pF		

<sup>[1]</sup> All typical values are measured at  $V_{CC}$  = 3.3 V (unless stated otherwise) and  $T_{amb}$  = 25 °C.

## 10. Dynamic characteristics

#### Table 7. Dynamic characteristics

Voltages are referenced to GND (ground = 0 V). For test circuit see <u>Figure 7</u>.

Symbol	Parameter	Conditions	T <sub>amb</sub> =	Unit			
				Min	Typ[1]	Max	
$t_{pd}$	propagation delay	CP to Qn; see Figure 6	[2]				ns ns ns
		V <sub>CC</sub> = 1.65 V to 1.95 V		1.0	2.8	4.7	ns
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		1.0	2.0	3.1	ns
		V <sub>CC</sub> = 2.7 V		1.0	2.2	2.9	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V		1.0	2.0	2.8	ns
C <sub>PD</sub>	power dissipation capacitance	per gate; $V_I = GND$ to $V_{CC}$ ; $V_{CC} = 3.3 \text{ V}$	[3]	-	25	-	pF

<sup>[1]</sup> Typical values are measured at  $T_{amb} = 25 \, ^{\circ}\text{C}$ 

$$P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \Sigma (C_L \times V_{CC}^2 \times f_o)$$
 where:

f<sub>i</sub> = input frequency in MHz; f<sub>o</sub> = output frequency in MHz

C<sub>L</sub> = output load capacitance in pF

V<sub>CC</sub> = supply voltage in Volts

N = number of inputs switching

 $\Sigma(C_L \times V_{CC}^2 \times f_0)$  = sum of the outputs

<sup>[2]</sup>  $t_{pd}$  is the same as  $t_{PHL}$  and  $t_{PLH}$ .

<sup>[3]</sup>  $C_{PD}$  is used to determine the dynamic power dissipation ( $P_D$  in  $\mu W$ ).

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## 11. Waveforms

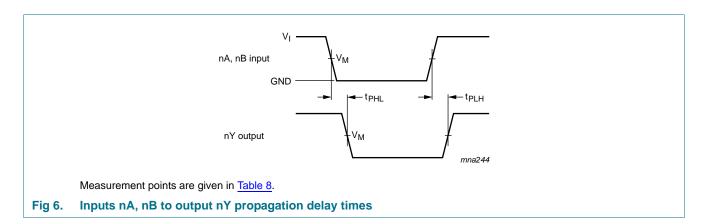
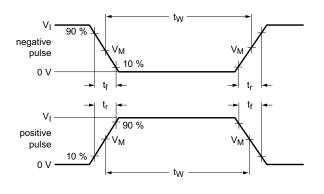
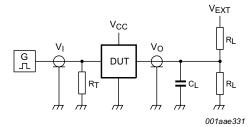


Table 8. Measurement points

Supply voltage V <sub>CC</sub>	Input V <sub>I</sub>	V <sub>M</sub>
1.65 V to 1.95 V	$V_{CC}$	0.5V <sub>CC</sub>
2.3 V to 2.7 V	V <sub>CC</sub>	0.5V <sub>CC</sub>
2.7 V	2.7 V	1.5 V
3.0 V to 3.6 V	2.7 V	1.5 V

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Test data is given in Table 9.

Definitions for test circuit:

R<sub>L</sub> = Load resistance.

 $C_L$  = Load capacitance including jig and probe capacitance.

 $R_T$  = Termination resistance should be equal to output impedance  $Z_o$  of the pulse generator.

 $V_{\text{EXT}}$  = External voltage for measuring switching times.

Fig 7. Test circuitry for measuring switching times

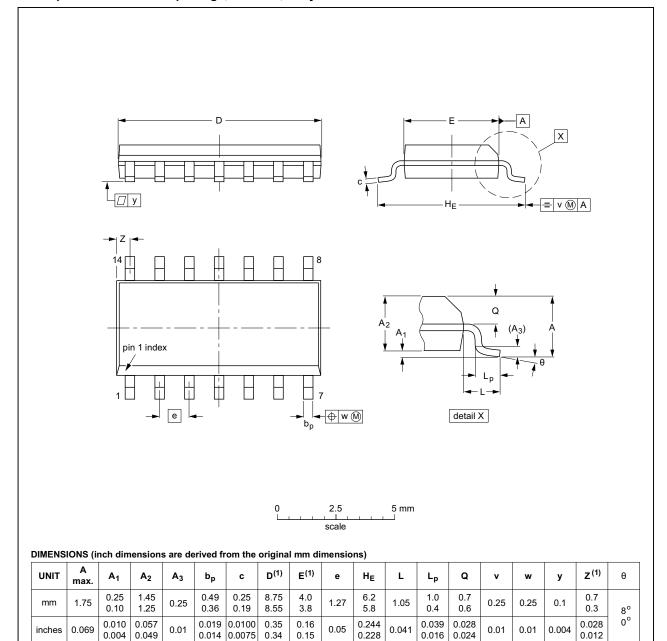
Table 9. Test data

Supply voltage V <sub>CC</sub>	Input		Load		V <sub>EXT</sub>	V <sub>EXT</sub>			
	VI	$V_{l}$ $t_{r}$ , $t_{f}$ $C_{L}$		R <sub>L</sub>	$t_{PLH}$ , $t_{PHL}$	$t_{PLZ}, t_{PZL}$	$t_{PHZ}$ , $t_{PZH}$		
1.65 V to 1.95 V	$V_{CC}$	$\leq$ 2.0 ns	30 pF	1 kΩ	open	$2\times V_{CC}$	GND		
2.3 V to 2.7 V	$V_{CC}$	≤ 2.0 ns	30 pF	$500\Omega$	open	$2\times V_{CC}$	GND		
2.7 V	2.7 V	≤ 2.5 ns	50 pF	$500 \Omega$	open	6 V	GND		
3.0 V to 3.6 V	2.7 V	≤ 2.5 ns	50 pF	$500 \Omega$	open	6 V	GND		

## 12. Package outline

#### SO14: plastic small outline package; 14 leads; body width 3.9 mm

SOT108-1



#### Note

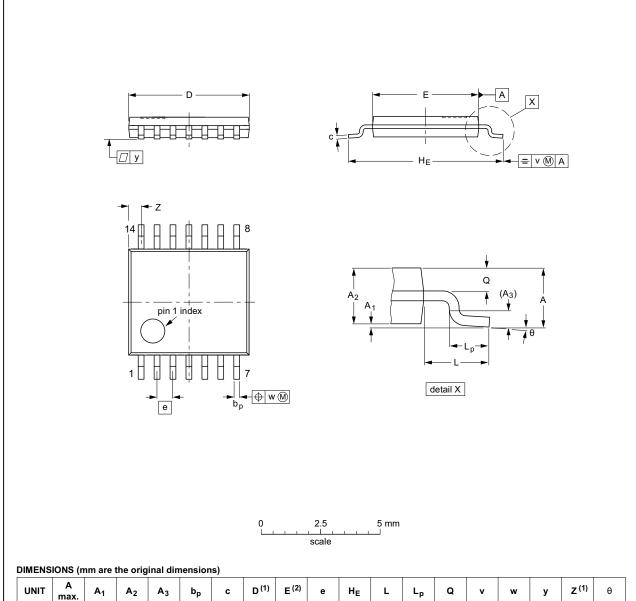
1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.

OUTLINE		REFER	EUROPEAN	ISSUE DATE			
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE	
SOT108-1	076E06	MS-012				<del>99-12-27</del> 03-02-19	

Fig 8. Package outline SOT108-1 (SO14)

TSSOP14: plastic thin shrink small outline package; 14 leads; body width 4.4 mm

SOT402-1



UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	<b>A</b> <sub>3</sub>	bp	С	D <sup>(1)</sup>	E (2)	е	HE	L	Lp	Q	v	w	у	Z <sup>(1)</sup>	θ
mm	1.1	0.15 0.05	0.95 0.80	0.25	0.30 0.19	0.2 0.1	5.1 4.9	4.5 4.3	0.65	6.6 6.2	1	0.75 0.50	0.4 0.3	0.2	0.13	0.1	0.72 0.38	8° 0°

#### Notes

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE	REFERENCES				EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
SOT402-1		MO-153				<del>99-12-27</del> 03-02-18

Fig 9. Package outline SOT402-1 (TSSOP14)

DHVQFN14: plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 14 terminals; body 2.5 x 3 x 0.85 mm SOT762-1

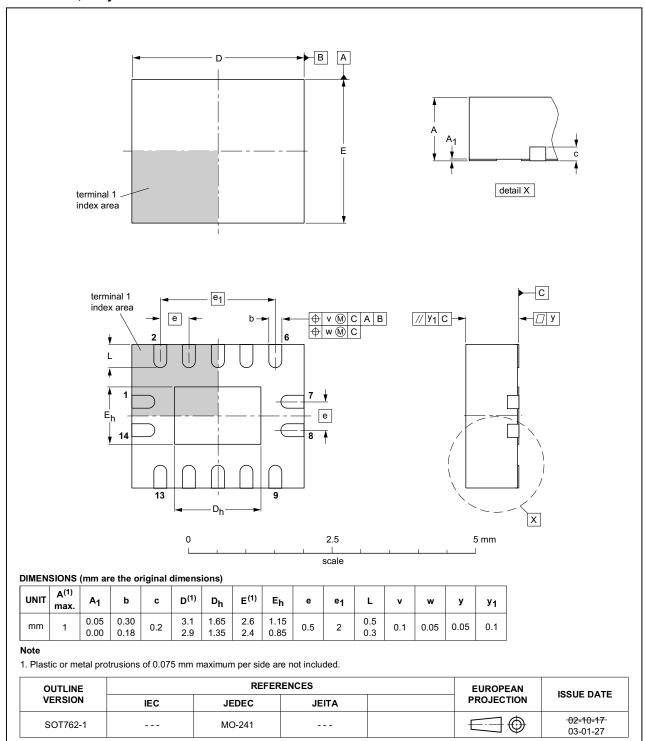


Fig 10. Package outline SOT762-1 (DHVQFN14)

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## 13. Abbreviations

#### Table 10. Abbreviations

Acronym	Description
CDM	Charged Device Model
DUT	Device Under Test
ESD	ElectroStatic Discharge
НВМ	Human Body Model
MM	Machine Model
TTL	Transistor-Transistor Logic

## 14. Revision history

#### Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes		
74ALVC32 v.3	20140120	Product data sheet	-	74ALVC32 v.2		
	<ul> <li>The format of to of NXP Semice</li> </ul>	this data sheet has been red onductors.	esigned to comply with	the new identity guidelines		
	<ul> <li>Legal texts have been adapted to the new company name where appropriate.</li> </ul>					
74ALVC32 v.2	20071210	Product data sheet	-	74ALVC32 v.1		
74ALVC32 v.1	20021115	Product specification	-	-		

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Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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#### **Quad 2-input OR gate**

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